

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10568449	AYEL ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	JASON M MANDEVILLE	2629

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	38,55,97-100,87-95	08 October 2009	Jason Mandeville

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	08 October 2009	Jason Mandeville
Inventor Search	08 October 2009	Jason Mandeville

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/J. M. M./  
Examiner Art Unit 2629